L Number	Hits	Search Text	DB	Time stamp
5	39	(gate with (trench adj isolation)) and (wrap adj around)	USPAT	2004/10/29 12:34
4	1253	gate with (trench adj isolation)	USPAT	2004/10/29 12:35
3	1147	438/400.ccls. or 438/424.ccls.	USPAT	2004/10/29 12:36
1	1406	438/780.ccls. or 438/787.ccls. or 438/791.ccls.	USPAT	2004/10/29 12:38
2	1787	438/595.ccls. or 438/758.ccls. or 438/778.ccls.	USPAT	2004/10/29 12:39
-	1343	438/780.ccls. or 438/787.ccls. or 438/791.ccls.	USPAT	2004/10/29 12:34
-	1724	438/595.ccls. or 438/758.ccls. or 438/778.ccls.	USPAT	2004/10/29 12:34
-	1208	gate with (trench adj isolation)	USPAT	2004/10/29 12:34
-	39	(gate with (trench adj isolation)) and (wrap adj around)	USPAT	2004/10/29 12:34
-	157	(semiconductor and dielectric and trench and sidewall and spacer).clm.	USPAT	2004/08/26 17:33
-	1123	438/400.ccls. or 438/424.ccls.	USPAT	2004/10/29 12:34
-	274	(438/400.ccls. or 438/424.ccls.) and ((gate adj wrap) or (parasitic adj capacitance) or (wrap adj around) or (spacer\$1 with sidewall) or (trench with spacer\$1) or (parasitic adj leakage))	USPAT	2004/08/27 17:39
-	2	(("5741738") or ("6184071")).PN.	USPAT	2004/08/30 18:25
-	13	''	USPAT	2004/08/30 18:59